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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination FERTLITSCH ET AL. | |
| | | Examiner Benjamin O. Dulaney | Art Unit 2625 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-----|--|-----------------|----------------------|----------------|
| * | A | US-5,128,878 A | 07-1992 | Gore et al. | 345/502 |
| * | B | US-5,287,194 A | 02-1994 | Lobiondo, Martin F. | 358/296 |
| * | C | US-5,940,186 A | 08-1999 | Barry et al. | 358/296 |
| * | D | US-5,982,996 A | 11-1999 | Snyders, Lawrence M. | 358/1.15 |
| * | E | US-6,049,394 A | 04-2000 | Fukushima, Tokutaro | 358/1.9 |
| * | F | US-6,609,210 B1 | 08-2003 | Onuma, Nobuo | 713/323 |
| * | G | US-6,665,082 B1 | 12-2003 | Takeoka et al. | 358/1.15 |
| * | H | US-6,863,367 B2 | 03-2005 | Hamamoto et al. | 347/23 |
| * | I | US-6,891,632 B2 | 05-2005 | Schwartz, Stephen | 358/1.15 |
| J | US- | | | | |
| K | US- | | | | |
| L | US- | | | | |
| M | US- | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
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NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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